

Notice of References Cited

Application/Control No.

10/043,465

Applicant(s)/Patent Under
Reexamination
GERLACH ET AL.

Examiner

Roy D. Gibson

Art Unit

3739

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,530,918	03-2003	Ueno et al.	606/10
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Data Sheets for 532 nm Lasers by JDS Uniphase Company.
	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.